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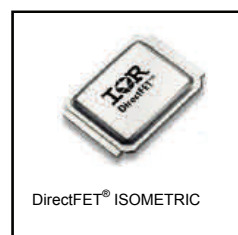
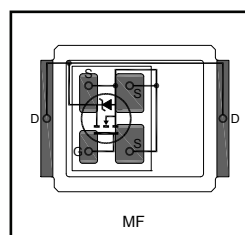
[International Rectifier \(Infineon Technologies Americas Corp.\)](#)  
[IRF7483MTRPBF](#)

For any questions, you can email us directly:

[sales@integrated-circuit.com](mailto:sales@integrated-circuit.com)

DirectFET® N-Channel Power MOSFET

|                                        |              |
|----------------------------------------|--------------|
| <b>V<sub>DSS</sub></b>                 | <b>40V</b>   |
| <b>R<sub>DS(on)</sub> typ.<br/>max</b> | <b>1.7mΩ</b> |
|                                        | <b>2.3mΩ</b> |
| <b>I<sub>D</sub> (Silicon Limited)</b> | <b>135A</b>  |



### Application

- Brushed Motor drive applications
- BLDC Motor drive applications
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters
- DC/AC Inverters

### Benefits

- Improved Gate, Avalanche and Dynamic dv/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dv/dt and di/dt Capability
- Lead-Free, RoHS Compliant

| Base part number | Package Type  | Standard Pack |          | Orderable Part Number |
|------------------|---------------|---------------|----------|-----------------------|
|                  |               | Form          | Quantity |                       |
| IRF7483MPbF      | DirectFET® MF | Tape and Reel | 4800     | IRF7483MTRPbF         |

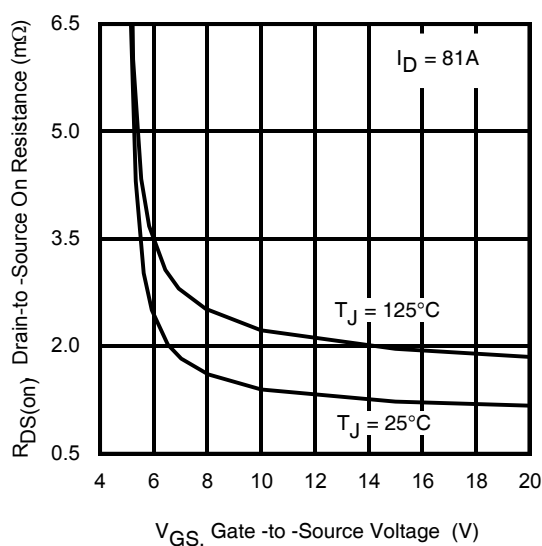


Fig 1. Typical On-Resistance vs. Gate Voltage

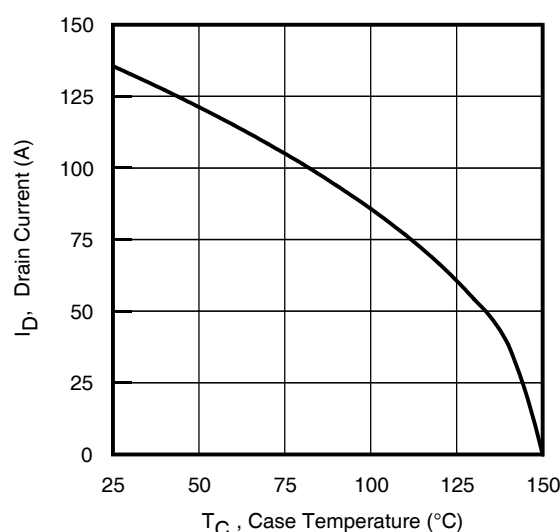


Fig 2. Maximum Drain Current vs. Case Temperature

### Absolute Maximum Ratings

| Symbol                          | Parameter                                                         | Max.         | Units |
|---------------------------------|-------------------------------------------------------------------|--------------|-------|
| $I_D @ T_C = 25^\circ\text{C}$  | Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited) | 135          | A     |
| $I_D @ T_C = 100^\circ\text{C}$ | Continuous Drain Current, $V_{GS} @ 10\text{V}$ (Silicon Limited) | 86           |       |
| $I_{DM}$                        | Pulsed Drain Current ①                                            | 540          |       |
| $P_D @ T_C = 25^\circ\text{C}$  | Maximum Power Dissipation                                         | 74           | W     |
|                                 | Linear Derating Factor                                            | 0.59         | W/°C  |
| $V_{GS}$                        | Gate-to-Source Voltage                                            | $\pm 20$     | V     |
| $T_J$                           | Operating Junction and                                            | -55 to + 150 | °C    |
| $T_{STG}$                       | Storage Temperature Range                                         |              |       |

### Avalanche Characteristics

|                              |                                              |                         |    |
|------------------------------|----------------------------------------------|-------------------------|----|
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ②              | 69                      | mJ |
| $E_{AS}$ (Thermally limited) | Single Pulse Avalanche Energy ⑩              | 152                     |    |
| $E_{AS}$ (tested)            | Single Pulse Avalanche Energy Tested Value ⑨ | 147                     |    |
| $I_{AR}$                     | Avalanche Current ①                          | See Fig.15,16, 23a, 23b | A  |
| $E_{AR}$                     | Repetitive Avalanche Energy ①                |                         | mJ |

### Thermal Resistance

| Symbol             | Parameter               | Typ. | Max. | Units |
|--------------------|-------------------------|------|------|-------|
| $R_{\theta JA}$    | Junction-to-Ambient ①   | —    | 60   | °C/W  |
| $R_{\theta JA}$    | Junction-to-Ambient ③   | 12.5 | —    |       |
| $R_{\theta JA}$    | Junction-to-Ambient ②   | 20   | —    |       |
| $R_{\theta JC}$    | Junction-to-Case ④⑧     | —    | 1.7  |       |
| $R_{\theta J-PCB}$ | Junction-to-PCB Mounted | 1.0  | —    |       |

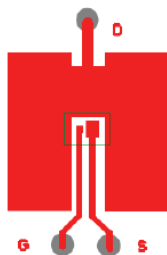
### Static @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

| Symbol                          | Parameter                            | Min. | Typ. | Max. | Units | Conditions                                                               |
|---------------------------------|--------------------------------------|------|------|------|-------|--------------------------------------------------------------------------|
| $V_{(BR)DSS}$                   | Drain-to-Source Breakdown Voltage    | 40   | —    | —    | V     | $V_{GS} = 0\text{V}$ , $I_D = 250\mu\text{A}$                            |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient  | —    | 32   | —    | mV/°C | Reference to $25^\circ\text{C}$ , $I_D = 1.0\text{mA}$ ①                 |
| $R_{DS(on)}$                    | Static Drain-to-Source On-Resistance | —    | 1.7  | 2.3  | mΩ    | $V_{GS} = 10\text{V}$ , $I_D = 81\text{A}$ ④                             |
|                                 |                                      | —    | 3.4  | —    |       | $V_{GS} = 6.0\text{V}$ , $I_D = 41\text{A}$ ④                            |
| $V_{GS(th)}$                    | Gate Threshold Voltage               | 2.2  | 3.0  | 3.9  | V     | $V_{DS} = V_{GS}$ , $I_D = 100\mu\text{A}$                               |
| $I_{DSS}$                       | Drain-to-Source Leakage Current      | —    | —    | 1.0  | μA    | $V_{DS} = 40\text{V}$ , $V_{GS} = 0\text{V}$                             |
|                                 |                                      | —    | —    | 150  |       | $V_{DS} = 40\text{V}$ , $V_{GS} = 0\text{V}$ , $T_J = 125^\circ\text{C}$ |
| $I_{GSS}$                       | Gate-to-Source Forward Leakage       | —    | —    | 100  | nA    | $V_{GS} = 20\text{V}$                                                    |
|                                 | Gate-to-Source Reverse Leakage       | —    | —    | -100 |       | $V_{GS} = -20\text{V}$                                                   |
| $R_G$                           | Internal Gate Resistance             | —    | 1.2  | —    | Ω     |                                                                          |

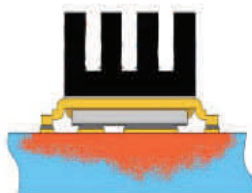
#### Notes:

- ① Mounted on minimum footprint full size board with metalized back and with small clip heatsink.
- ② Used double sided cooling , mounting pad with large heatsink.

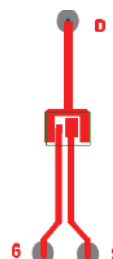
- ④ TC measured with thermocouple mounted to top (Drain) of part.



- ① Surface mounted on 1 in. square Cu board (still air).



- ② Mounted to a PCB with small clip heatsink (still air)

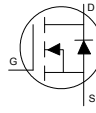


- ③ Mounted on minimum footprint full size board with metalized back and with small clip heatsink (still air)

**Dynamic @  $T_J = 25^\circ\text{C}$  (unless otherwise specified)**

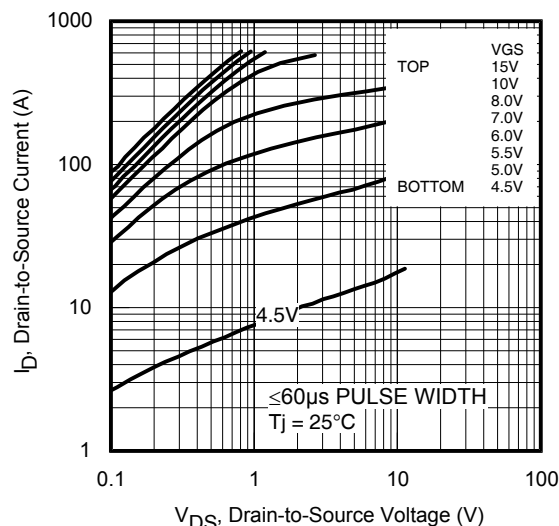
| Symbol                      | Parameter                                     | Min. | Typ. | Max. | Units | Conditions                                                        |
|-----------------------------|-----------------------------------------------|------|------|------|-------|-------------------------------------------------------------------|
| gfs                         | Forward Transconductance                      | 125  | —    | —    | S     | $V_{DS} = 10\text{V}$ , $I_D = 81\text{A}$                        |
| $Q_g$                       | Total Gate Charge                             | —    | 81   | —    | nC    | $I_D = 81\text{A}$                                                |
| $Q_{gs}$                    | Gate-to-Source Charge                         | —    | 21   | —    |       | $V_{DS} = 20\text{V}$                                             |
| $Q_{gd}$                    | Gate-to-Drain ("Miller") Charge               | —    | 28   | —    |       | $V_{GS} = 10\text{V}$ ④                                           |
| $Q_{sync}$                  | Total Gate Charge Sync. ( $Q_g - Q_{gd}$ )    | —    | 53   | —    |       | $I_D = 81\text{A}$ , $V_{DS} = 0\text{V}$ , $V_{GS} = 10\text{V}$ |
| $t_{d(on)}$                 | Turn-On Delay Time                            | —    | 15   | —    | ns    | $V_{DD} = 20\text{V}$                                             |
| $t_r$                       | Rise Time                                     | —    | 53   | —    |       | $I_D = 30\text{A}$                                                |
| $t_{d(off)}$                | Turn-Off Delay Time                           | —    | 39   | —    |       | $R_G = 2.7\Omega$                                                 |
| $t_f$                       | Fall Time                                     | —    | 25   | —    |       | $V_{GS} = 10\text{V}$ ④                                           |
| $C_{iss}$                   | Input Capacitance                             | —    | 3913 | —    | pF    | $V_{GS} = 0\text{V}$                                              |
| $C_{oss}$                   | Output Capacitance                            | —    | 642  | —    |       | $V_{DS} = 25\text{V}$                                             |
| $C_{rss}$                   | Reverse Transfer Capacitance                  | —    | 431  | —    |       | $f = 1.0\text{MHz}$                                               |
| $C_{oss \text{ eff. (ER)}}$ | Effective Output Capacitance (Energy Related) | —    | 765  | —    |       | $V_{GS} = 0\text{V}$ , $V_{DS} = 0\text{V}$ to $32\text{V}$ ⑥     |
| $C_{oss \text{ eff. (TR)}}$ | Effective Output Capacitance (Time Related)   | —    | 932  | —    |       | $V_{GS} = 0\text{V}$ , $V_{DS} = 0\text{V}$ to $32\text{V}$ ⑤     |

**Diode Characteristics**

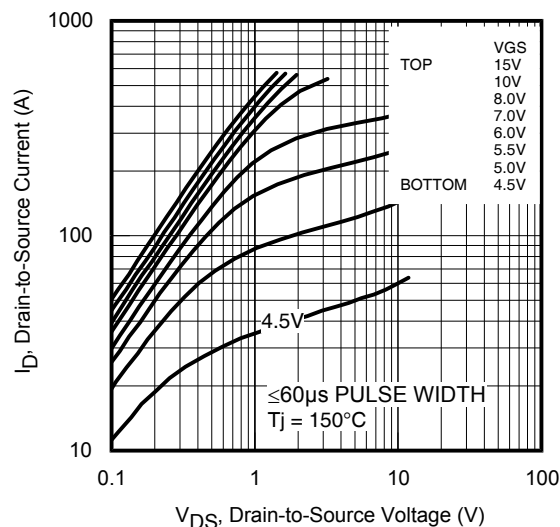
| Symbol    | Parameter                              | Min. | Typ. | Max. | Units | Conditions                                                                                                                                         |
|-----------|----------------------------------------|------|------|------|-------|----------------------------------------------------------------------------------------------------------------------------------------------------|
| $I_S$     | Continuous Source Current (Body Diode) | —    | —    | 74   | A     | MOSFET symbol showing the integral reverse p-n junction diode.  |
| $I_{SM}$  | Pulsed Source Current (Body Diode) ①   | —    | —    | 540  |       |                                                                                                                                                    |
| $V_{SD}$  | Diode Forward Voltage                  | —    | —    | 1.2  | V     | $T_J = 25^\circ\text{C}$ , $I_S = 81\text{A}$ , $V_{GS} = 0\text{V}$ ④                                                                             |
| $dv/dt$   | Peak Diode Recovery ③                  | —    | 2.4  | —    | V/ns  | $T_J = 150^\circ\text{C}$ , $I_S = 81\text{A}$ , $V_{DS} = 40\text{V}$                                                                             |
| $t_{rr}$  | Reverse Recovery Time                  | —    | 38   | —    | ns    | $T_J = 25^\circ\text{C}$ $V_R = 34\text{V}$ ,<br>$T_J = 125^\circ\text{C}$ $I_F = 81\text{A}$                                                      |
| $Q_{rr}$  | Reverse Recovery Charge                | —    | 42   | —    |       | $T_J = 25^\circ\text{C}$ $di/dt = 100\text{A}/\mu\text{s}$ ④<br>$T_J = 125^\circ\text{C}$                                                          |
| $I_{RRM}$ | Reverse Recovery Current               | —    | 1.9  | —    | A     | $T_J = 25^\circ\text{C}$                                                                                                                           |

**Notes:**

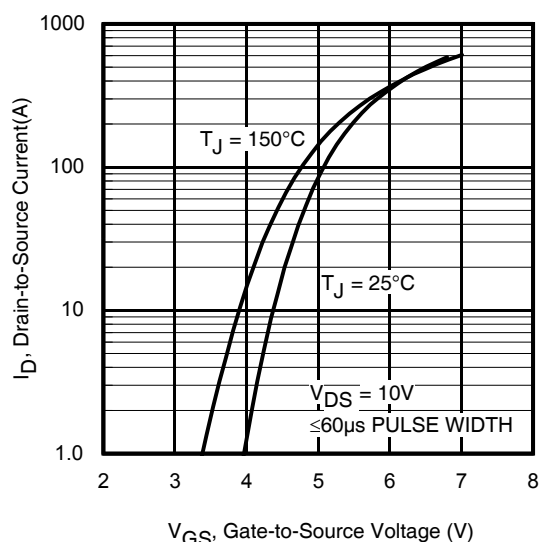
- ① Repetitive rating; pulse width limited by max. junction temperature.
- ② Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.021\text{mH}$   
 $R_G = 50\Omega$ ,  $I_{AS} = 81\text{A}$ ,  $V_{GS} = 10\text{V}$ .
- ③  $I_{SD} \leq 81\text{A}$ ,  $di/dt \leq 839\text{A}/\mu\text{s}$ ,  $V_{DD} \leq V_{(BR)DSS}$ ,  $T_J \leq 150^\circ\text{C}$ .
- ④ Pulse width  $\leq 400\mu\text{s}$ ; duty cycle  $\leq 2\%$ .
- ⑤  $C_{oss \text{ eff. (TR)}}$  is a fixed capacitance that gives the same charging time as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑥  $C_{oss \text{ eff. (ER)}}$  is a fixed capacitance that gives the same energy as  $C_{oss}$  while  $V_{DS}$  is rising from 0 to 80%  $V_{DSS}$ .
- ⑦ When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note # AN-994.  
<http://www.irf.com/technical-info/appnotes/an-994.pdf>
- ⑧  $R_\theta$  is measured at  $T_J$  approximately  $90^\circ\text{C}$ .
- ⑨ This value determined from sample failure population, starting  $T_J = 25^\circ\text{C}$ ,  $L = 0.021\text{mH}$ ,  $R_G = 50\Omega$ ,  $I_{AS} = 81\text{A}$ ,  $V_{GS} = 10\text{V}$ .
- ⑩ Limited by  $T_{Jmax}$ , starting  $T_J = 25^\circ\text{C}$ ,  $L = 1\text{mH}$   
 $R_G = 50\Omega$ ,  $I_{AS} = 17\text{A}$ ,  $V_{GS} = 10\text{V}$ .



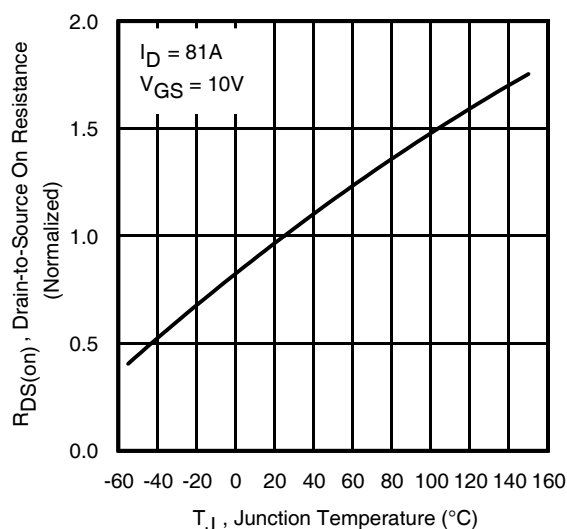
**Fig 3.** Typical Output Characteristics



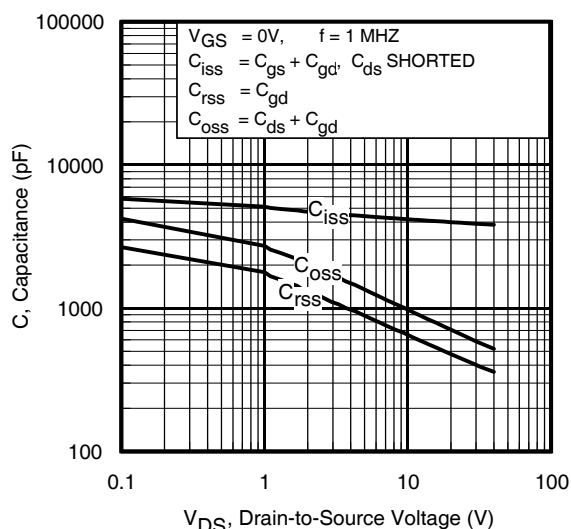
**Fig 4.** Typical Output Characteristics



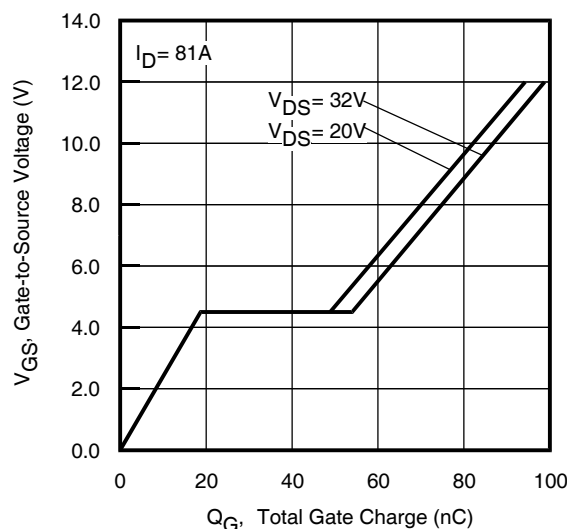
**Fig 5.** Typical Transfer Characteristics



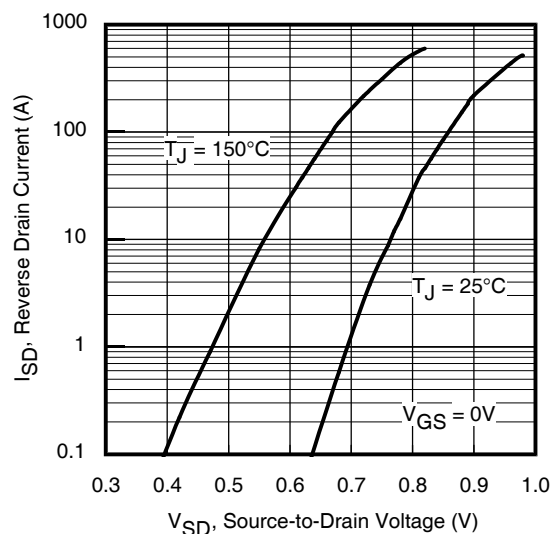
**Fig 6.** Normalized On-Resistance vs. Temperature



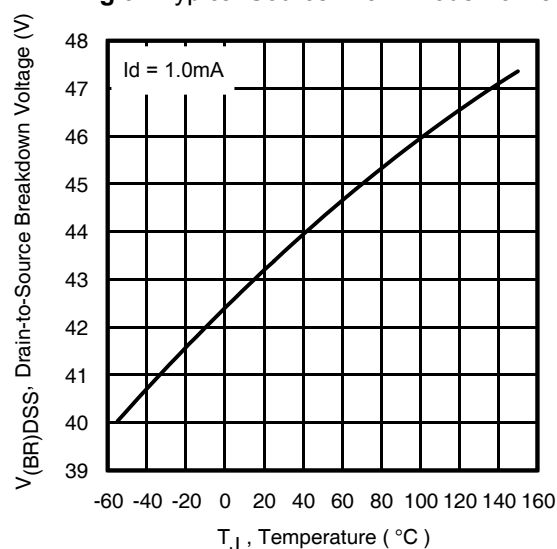
**Fig 7.** Typical Capacitance vs. Drain-to-Source Voltage



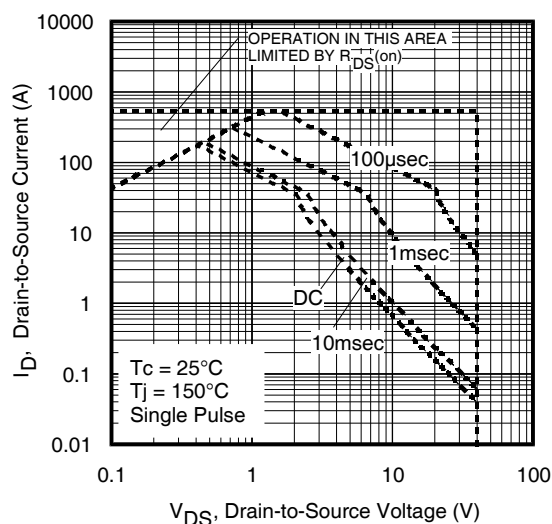
**Fig 8.** Typical Gate Charge vs. Gate-to-Source Voltage



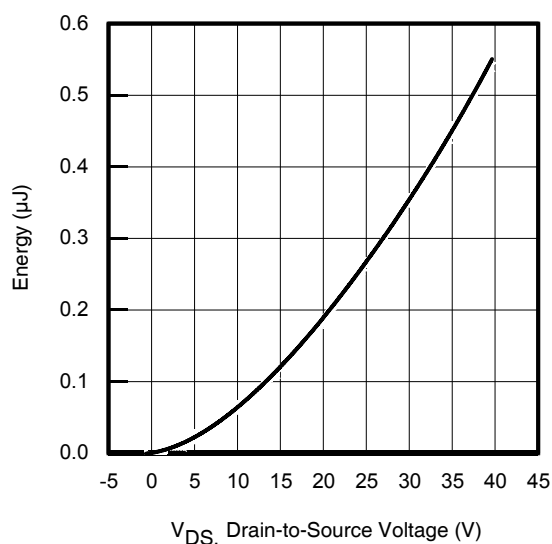
**Fig 9.** Typical Source-Drain Diode Forward Voltage



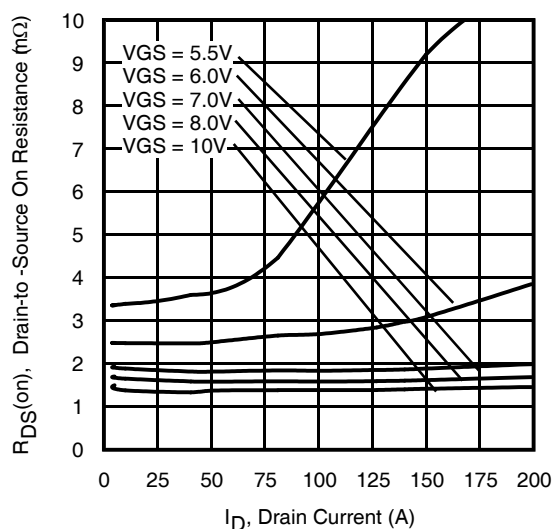
**Fig 11.** Drain-to-Source Breakdown Voltage



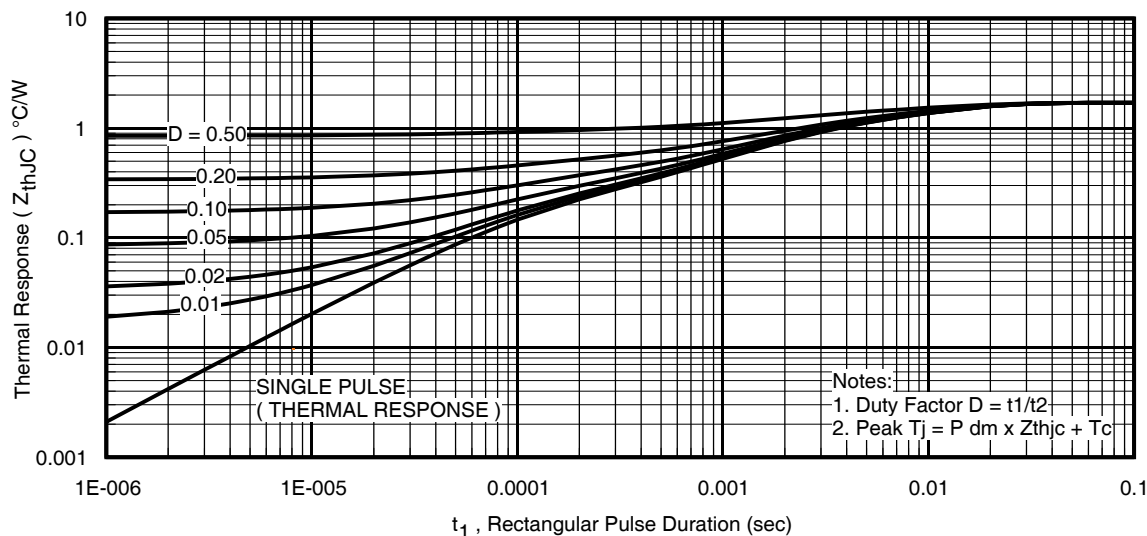
**Fig 10.** Maximum Safe Operating Area



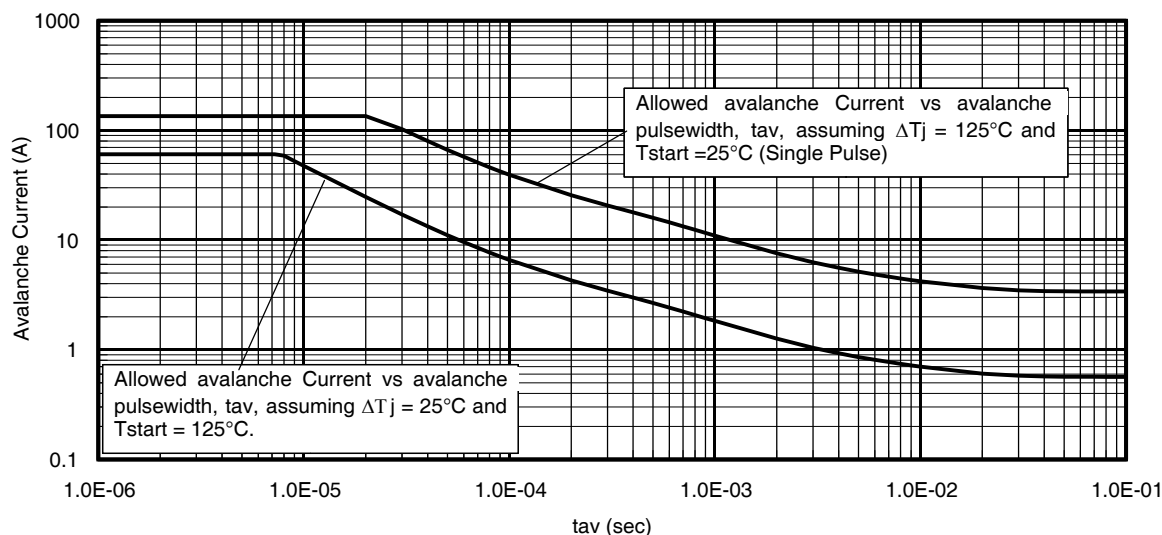
**Fig 12.** Typical  $C_{oss}$  Stored Energy



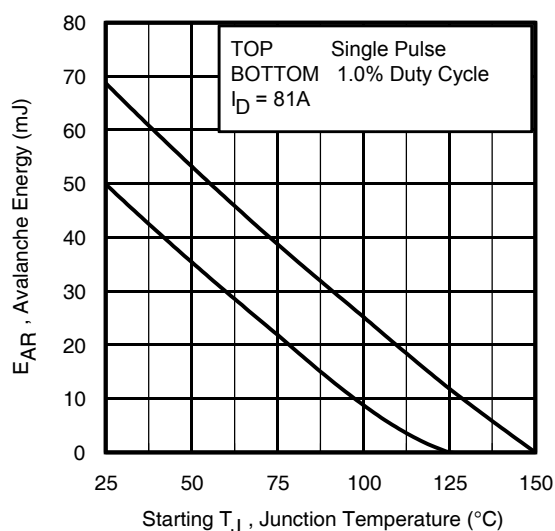
**Fig 13.** Typical On-Resistance vs. Drain Current



**Fig 14.** Maximum Effective Transient Thermal Impedance, Junction-to-Case



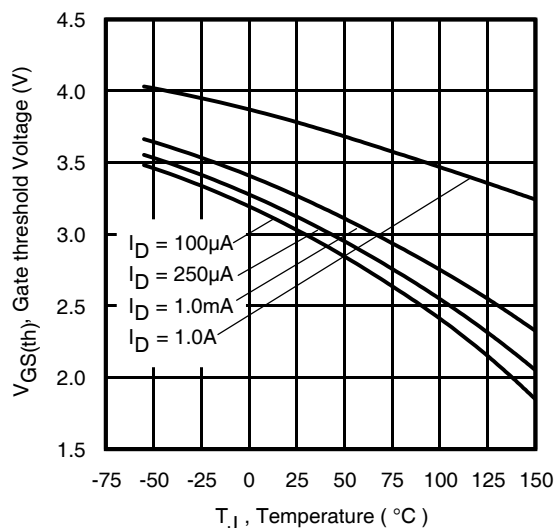
**Fig 15.** Avalanche Current vs. Pulse Width



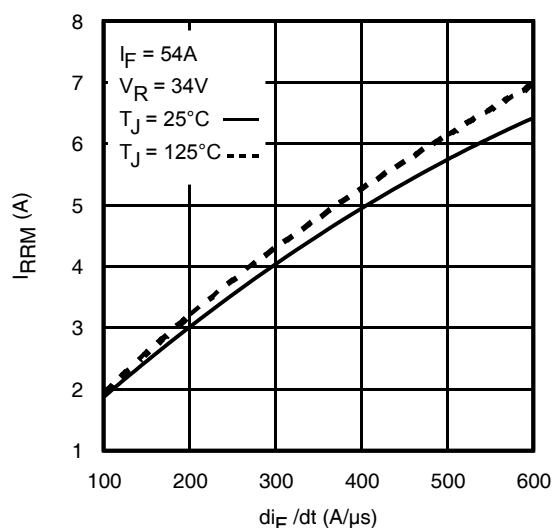
**Fig 16.** Maximum Avalanche Energy vs. Temperature

**Notes on Repetitive Avalanche Curves , Figures 15, 16:  
(For further info, see AN-1005 at www.irf.com)**

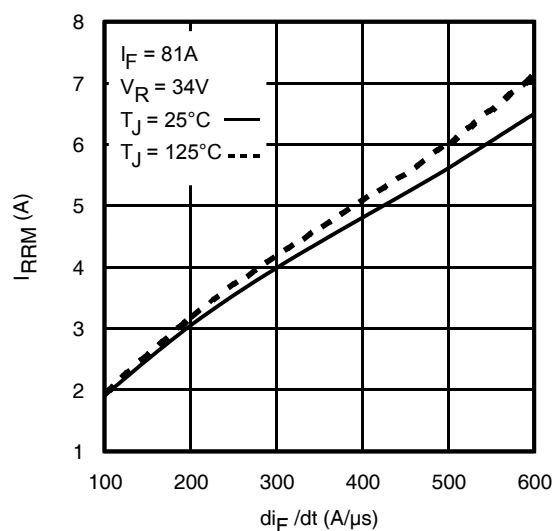
1. Avalanche failures assumption:  
Purely a thermal phenomenon and failure occurs at a temperature far in excess of  $T_{jmax}$ . This is validated for every part type.
2. Safe operation in Avalanche is allowed as long as  $T_{jmax}$  is not exceeded.
3. Equation below based on circuit and waveforms shown in Figures 23a, 23b.
4.  $P_{D(ave)}$  = Average power dissipation per single avalanche pulse.
5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
6.  $I_{av}$  = Allowable avalanche current.
7.  $\Delta T$  = Allowable rise in junction temperature, not to exceed  $T_{jmax}$  (assumed as 25°C in Figure 14, 15).  
 $t_{av}$  = Average time in avalanche.  
 $D$  = Duty cycle in avalanche =  $t_{av} \cdot f$   
 $Z_{thJC}(D, t_{av})$  = Transient thermal resistance, see Figures 13)  
 $P_{D(ave)} = 1/2 (1.3 \cdot BV \cdot I_{av}) = \Delta T / Z_{thJC}$   
 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$   
 $E_{AS(AR)} = P_{D(ave)} \cdot t_{av}$



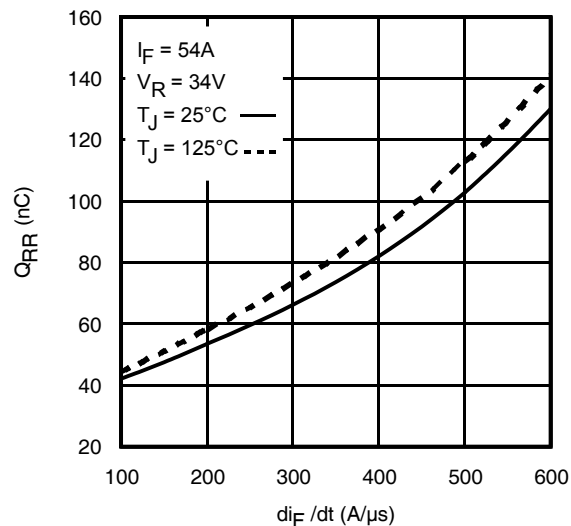
**Fig 17.** Threshold Voltage vs. Temperature



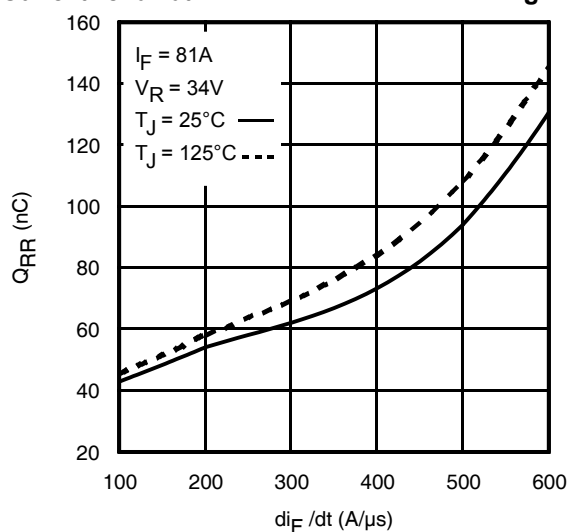
**Fig 18.** Typical Recovery Current vs.  $di_F/dt$



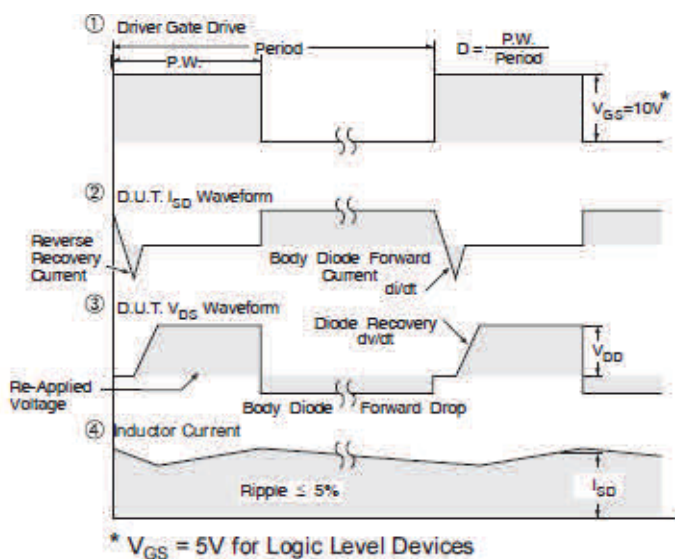
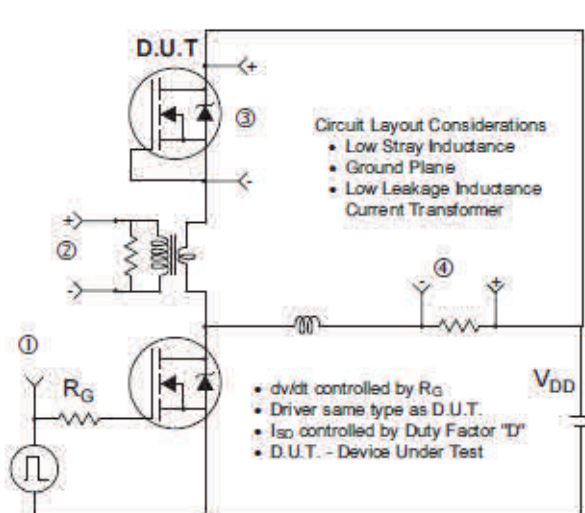
**Fig 19.** Typical Recovery Current vs.  $di_F/dt$



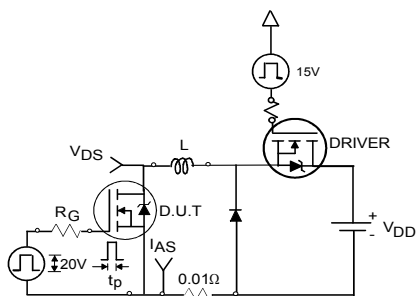
**Fig 20.** Typical Stored Charge vs.  $di_F/dt$



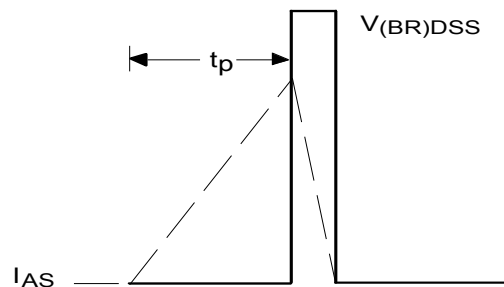
**Fig 21.** Typical Stored Charge vs.  $di_F/dt$



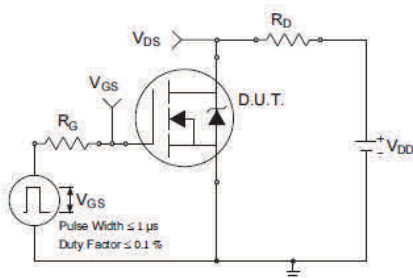
**Fig 22.** Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs



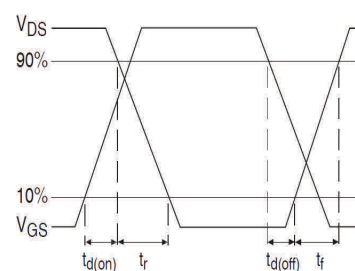
**Fig 23a.** Unclamped Inductive Test Circuit



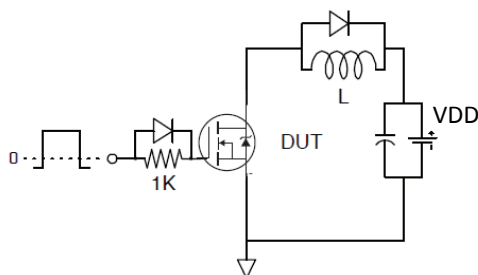
**Fig 23b.** Unclamped Inductive Waveforms



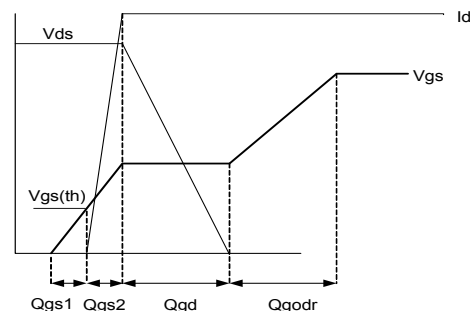
**Fig 24a.** Switching Time Test Circuit



**Fig 24b.** Switching Time Waveforms



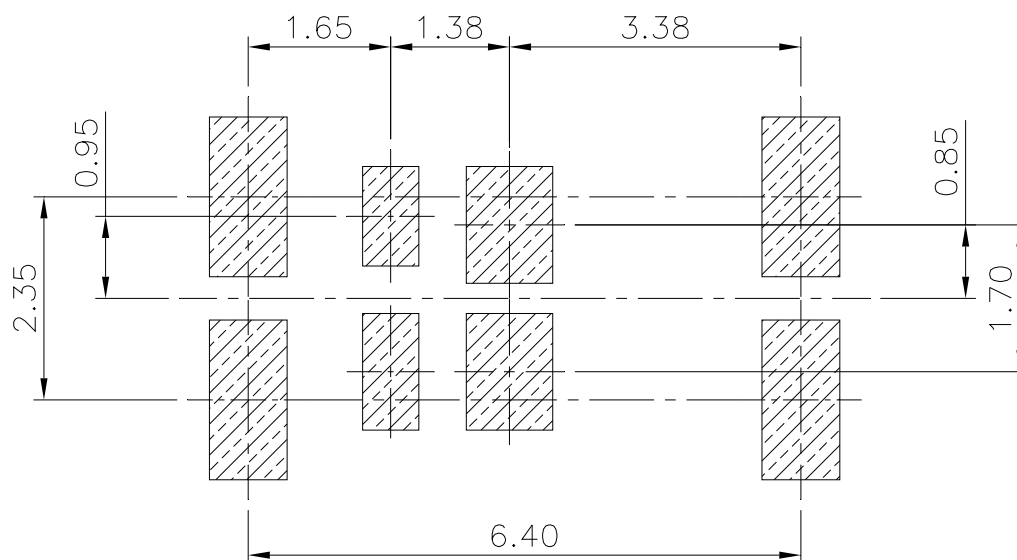
**Fig 25a.** Gate Charge Test Circuit



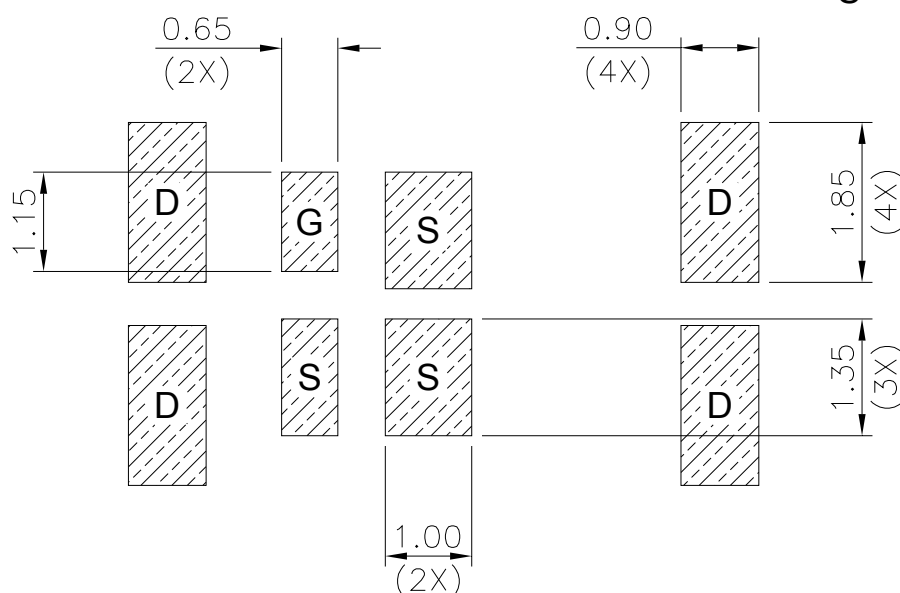
**Fig 25b.** Gate Charge Waveform

**DirectFET® Board Footprint, MF Outline  
(Medium Size Can, E-Designation)**

Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET®. This includes all recommendations for stencil and substrate designs.



G = GATE  
D = DRAIN  
S = SOURCE

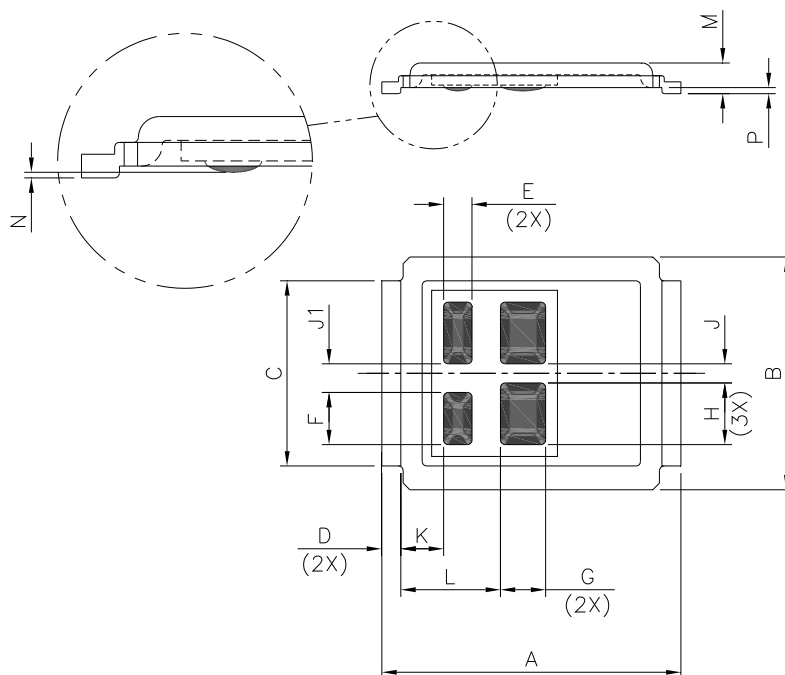


Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

## DirectFET® Outline Dimension, MF Outline

### (Medium Size Can, E-Designation)

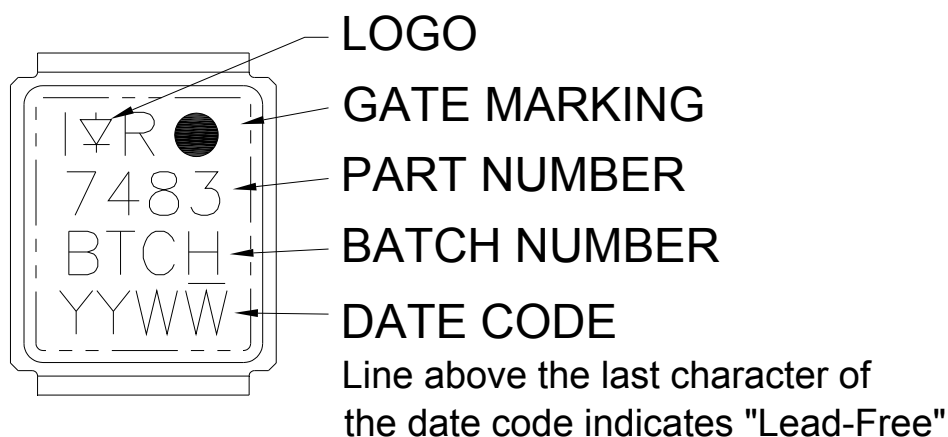
Please see DirectFET® application note AN-1035 for all details regarding the assembly of DirectFET®. This includes all recommendations for stencil and substrate designs.



| CODE | METRIC |      | IMPERIAL |       |
|------|--------|------|----------|-------|
|      | MIN    | MAX  | MIN      | MAX   |
| A    | 6.25   | 6.35 | 0.246    | 0.250 |
| B    | 4.80   | 5.05 | 0.189    | 0.199 |
| C    | 3.85   | 3.95 | 0.152    | 0.156 |
| D    | 0.35   | 0.45 | 0.014    | 0.018 |
| E    | 0.58   | 0.62 | 0.023    | 0.024 |
| F    | 1.08   | 1.12 | 0.043    | 0.044 |
| G    | 0.93   | 0.97 | 0.037    | 0.038 |
| H    | 1.28   | 1.32 | 0.050    | 0.052 |
| J    | 0.38   | 0.42 | 0.015    | 0.017 |
| J1   | 0.58   | 0.62 | 0.023    | 0.024 |
| K    | 0.88   | 0.92 | 0.035    | 0.036 |
| L    | 2.08   | 2.12 | 0.082    | 0.083 |
| M    | 0.59   | 0.70 | 0.023    | 0.028 |
| N    | 0.02   | 0.08 | 0.0008   | 0.003 |
| P    | 0.08   | 0.17 | 0.003    | 0.007 |

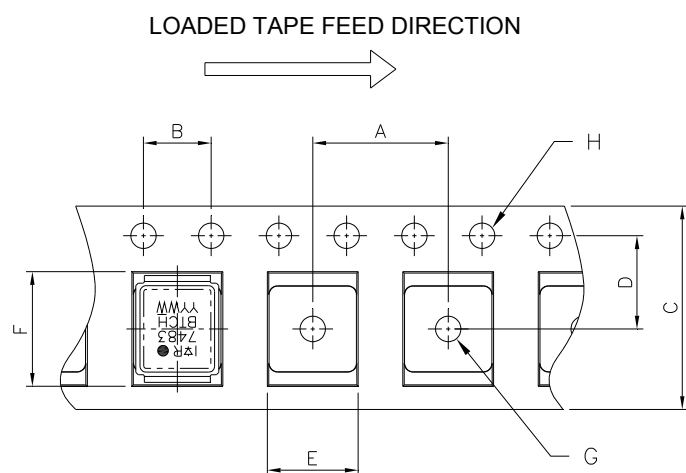
Dimensions are shown in  
millimeters (inches)

## DirectFET® Part Marking



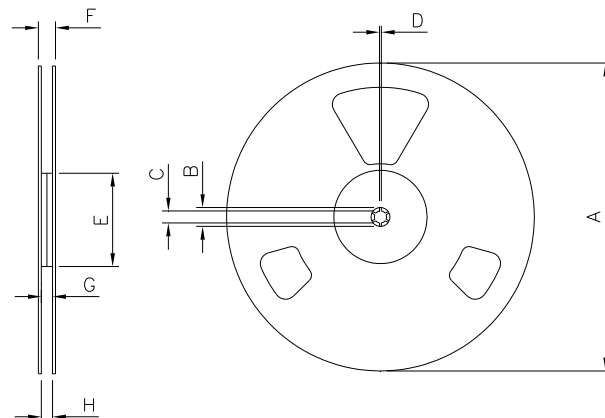
Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**DirectFET® Tape & Reel Dimension (Showing component orientation).**



NOTE: CONTROLLING  
DIMENSIONS IN MM

| CODE | DIMENSIONS |       |          |       |
|------|------------|-------|----------|-------|
|      | METRIC     |       | IMPERIAL |       |
|      | MIN        | MAX   | MIN      | MAX   |
| A    | 7.90       | 8.10  | 0.311    | 0.319 |
| B    | 3.90       | 4.10  | 0.154    | 0.161 |
| C    | 11.90      | 12.30 | 0.469    | 0.484 |
| D    | 5.45       | 5.55  | 0.215    | 0.219 |
| E    | 5.10       | 5.30  | 0.201    | 0.209 |
| F    | 6.50       | 6.70  | 0.256    | 0.264 |
| G    | 1.50       | N.C   | 0.059    | N.C   |
| H    | 1.50       | 1.60  | 0.059    | 0.063 |



NOTE: Controlling dimensions in mm  
Std reel quantity is 4800 parts. (ordered as IRF7483MTRPBF). For 1000 parts on 7" reel, order IRF7483MTR1PBF

| REEL DIMENSIONS            |        |      |          |                       |          |        |          |
|----------------------------|--------|------|----------|-----------------------|----------|--------|----------|
| STANDARD OPTION (QTY 4800) |        |      |          | TR1 OPTION (QTY 1000) |          |        |          |
| CODE                       | METRIC |      | IMPERIAL | METRIC                | IMPERIAL | METRIC | IMPERIAL |
|                            | MIN    | MAX  |          |                       |          |        |          |
| A                          | 330.0  | N.C  | 12.992   | N.C                   | 177.77   | N.C    | 6.9      |
| B                          | 20.2   | N.C  | 0.795    | N.C                   | 19.06    | N.C    | 0.75     |
| C                          | 12.8   | 13.2 | 0.504    | 0.520                 | 13.5     | 12.8   | 0.53     |
| D                          | 1.5    | N.C  | 0.059    | N.C                   | 1.5      | N.C    | 0.059    |
| E                          | 100.0  | N.C  | 3.937    | N.C                   | 58.72    | N.C    | 2.31     |
| F                          | N.C    | 18.4 | N.C      | 0.724                 | N.C      | 13.50  | N.C      |
| G                          | 12.4   | 14.4 | 0.488    | 0.567                 | 11.9     | 12.01  | 0.47     |
| H                          | 11.9   | 15.4 | 0.469    | 0.606                 | 11.9     | 12.01  | 0.47     |

Note: For the most current drawing please refer to IR website at <http://www.irf.com/package/>

**Qualification Information<sup>†</sup>**

| Qualification Level        | Industrial *<br>(per JEDEC JESD47F <sup>††</sup> guidelines) |                                               |
|----------------------------|--------------------------------------------------------------|-----------------------------------------------|
| Moisture Sensitivity Level | DFET 1.5                                                     | MSL1<br>(per JEDEC J-STD-020D <sup>††</sup> ) |
| RoHS Compliant             | Yes                                                          |                                               |

<sup>†</sup> Qualification standards can be found at International Rectifier's web site

<http://www.irf.com/product-info/reliability>

<sup>††</sup> Applicable version of JEDEC standard at the time of product release.

\* Industrial qualification standards except autoclave test conditions.

**Revision History**

| Date       | Comments                                                                                                 |
|------------|----------------------------------------------------------------------------------------------------------|
| 05/14/2015 | • Updated registered trademark from DirectFET <sup>™</sup> to DirectFET <sup>®</sup> on page 1,9 and 10. |

International  
**IOR** Rectifier

IR WORLD HEADQUARTERS: 101 N. Sepulveda Blvd., El Segundo, California 90245, USA

To contact International Rectifier, please visit <http://www.irf.com/whoto-call/>